

# AP50T10GH-HF-VB Datasheet N-Channel 100-V (D-S) MOSFET

| PRODUCT SUMMARY     |                                  |                                 |                       |  |  |
|---------------------|----------------------------------|---------------------------------|-----------------------|--|--|
| V <sub>DS</sub> (V) | $R_{DS(on)}(\Omega)$             | I <sub>D</sub> (A) <sup>a</sup> | Q <sub>g</sub> (Typ.) |  |  |
| 100                 | 0.0185 at V <sub>GS</sub> = 10 V | 45                              | 38 nC                 |  |  |

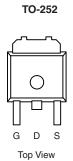
#### **FEATURES**

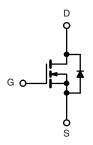
- Trench Power MOSFET
- 100 %  $\rm R_{\rm g}$  and UIS Tested





- Primary Side Switch
- Isolated DC/DC Converter





N-Channel MOSFET

| Parameter  |                                   | Symbol          | Limit            | Unit |  |
|--|-----------------------------------|-----------------|------------------|------|--|
| Drain-Source Voltage                               |                                   | V <sub>DS</sub> | 100              | V    |  |
| Gate-Source Voltage                                |                                   | V <sub>GS</sub> | ± 20             |      |  |
|  | T <sub>C</sub> = 25 °C            |                 | 45 <sup>a</sup>  |      |  |
| Continuous Drain Current /T 150 °C)                | T <sub>C</sub> = 100 °C           |                 | 30               |      |  |
| Continuous Drain Current (T <sub>J</sub> = 150 °C) | T <sub>A</sub> = 25 °C            | I <sub>D</sub>  | 9.2 <sup>b</sup> |      |  |
|  | T <sub>A</sub> = 100 °C           |                 | 6.8 <sup>b</sup> |      |  |
| Pulsed Drain Current                               |                                   | I <sub>DM</sub> | 140              | Α    |  |
| Continuous Source-Drain Diode Current              | T <sub>C</sub> = 25 °C            | 1               | 45 <sup>a</sup>  |      |  |
| Continuous Source-Diam blode Current               | T <sub>A</sub> = 25 °C            | I <sub>S</sub>  | 2 <sup>b</sup>   |      |  |
| Single Pulse Avalanche Current                     | L = 0.1 mH                        | I <sub>AS</sub> | 35               |      |  |
| Avalanche Energy                                   | L = U.T IIII                      | E <sub>AS</sub> | 101              | mJ   |  |
| Maximum Power Dissipation                          | T <sub>C</sub> = 25 °C            |                 | 136.4            | w    |  |
|  | T <sub>C</sub> = 100 °C           | В               | 68.2             |      |  |
|  | T <sub>A</sub> = 25 °C            | P <sub>D</sub>  | 3 <sup>b</sup>   | ¬    |  |
|  | T <sub>A</sub> = 100 °C           |                 | 1.5 <sup>b</sup> |      |  |
| Operating Junction and Storage Temperature Ra      | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 175     | °C               |      |  |

| THERMAL RESISTANCE RATINGS               |              |                   |         |         |      |
|--|--------------|-------------------|---------|---------|------|
| Parameter                                |              | Symbol            | Typical | Maximum | Unit |
| Maximum Junction-to-Ambient <sup>b</sup> | Steady State | R <sub>thJA</sub> | 40      | 50      | °C/W |
| Maximum Junction-to-Case                 | Sieauy State | R <sub>thJC</sub> | 0.85    | 1.1     | C/VV |

#### Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.



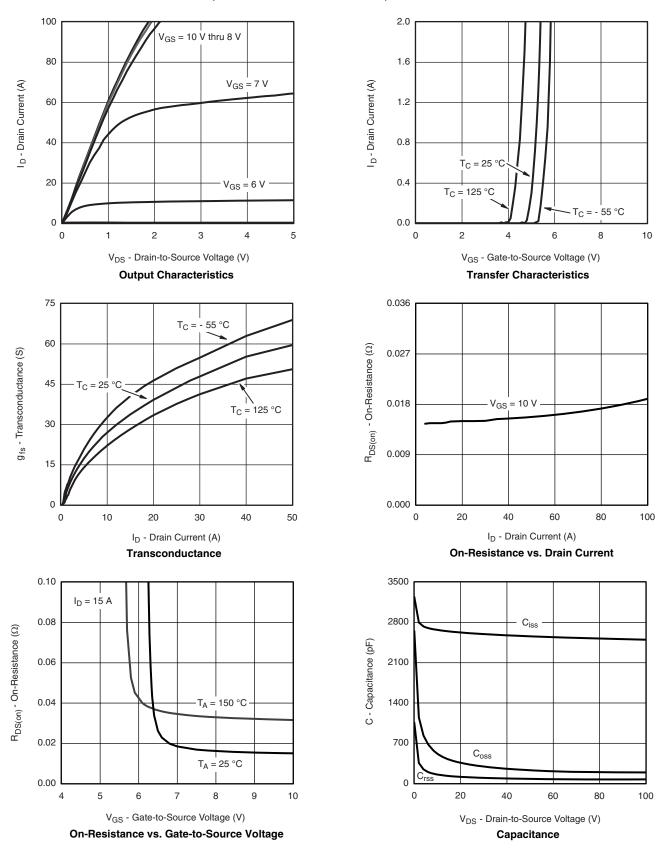
| Parameter  | Symbol                  | Test Conditions   | Min. | Тур.   | Max.  | Unit  |
|--|-------------------------|---|------|--------|-------|-------|
| Static   |                         |   |      |        |       |       |
| Drain-Source Breakdown Voltage                   | V <sub>DS</sub>         | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$   | 100  |        |       | V     |
| V <sub>DS</sub> Temperature Coefficient          | $\Delta V_{DS}/T_{J}$   | J 050 A   |      | 110    |       | mV/°C |
| V <sub>GS(th)</sub> Temperature Coefficient      | $\Delta V_{GS(th)}/T_J$ | l <sub>D</sub> = 250 μA   |      | - 12.5 |       |       |
| Gate-Source Threshold Voltage                    | V <sub>GS(th)</sub>     | $V_{DS} = V_{GS}, I_D = 250 \mu A$  | 2.5  |        | 5     | V     |
| Gate-Source Leakage                              | I <sub>GSS</sub>        | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$   |      |        | ± 100 | nA    |
| Zone Oode Walke on Durin Oom                     | I <sub>DSS</sub>        | V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V  | 1    |        | 1     |       |
| Zero Gate Voltage Drain Current                  |                         | V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C                                     |      |        | 50    | μΑ    |
| On-State Drain Current <sup>a</sup>              | I <sub>D(on)</sub>      | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$   | 30   |        |       | Α     |
| Drain-Source On-State Resistance <sup>a</sup>    | R <sub>DS(on)</sub>     | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A   |      | 0.0185 |       | Ω     |
| Forward Transconductance <sup>a</sup>            | g <sub>fs</sub>         | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A   |      | 33     |       | S     |
| Dynamic <sup>b</sup>                             |                         |   |      |        |       |       |
| Input Capacitance                                | C <sub>iss</sub>        |   |      | 2400   |       | pF    |
| Output Capacitance                               | C <sub>oss</sub>        | $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$  |      | 230    |       |       |
| Reverse Transfer Capacitance                     | C <sub>rss</sub>        |   |      | 80     |       |       |
| Total Gate Charge                                | $Q_g$                   |   |      | 38     | 70    | nC    |
| Gate-Source Charge                               | Q <sub>gs</sub>         | $V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 50 \text{ A}$  |      | 14     |       |       |
| Gate-Drain Charge                                | Q <sub>gd</sub>         |   |      | 12     |       |       |
| Gate Resistance                                  | $R_g$                   | f = 1 MHz   |      | 1.6    | 2.5   | Ω     |
| urn-On Delay Time t <sub>d(on)</sub>             |                         |   |      | 12     | 20    |       |
| Rise Time  | t <sub>r</sub>          | $V_{DD} = 50 \text{ V}, R_L = 1 \Omega$<br>$I_D \cong 50 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$ |      | 10     | 20    | ns    |
| Turn-Off Delay Time                              | t <sub>d(off)</sub>     |   |      | 18     | 35    |       |
| Fall Time  | t <sub>f</sub>          |   |      | 8      | 15    |       |
| Drain-Source Body Diode Characteris              | stics                   |   |      |        |       |       |
| Continuous Source-Drain Diode                    | I <sub>S</sub>          | T <sub>C</sub> = 25 °C  |      |        | 35    | A     |
| Pulse Diode Forward Current <sup>a</sup>         | I <sub>SM</sub>         | _   |      |        | 100   |       |
| Body Diode Voltage                               | $V_{SD}$                | I <sub>S</sub> = 15 A   |      | 0.85   | 1.5   | V     |
| Body Diode Reverse Recovery Time t <sub>rr</sub> |                         |   |      | 80     | 120   | ns    |
| Body Diode Reverse Recovery Charge               | Q <sub>rr</sub>         | I <sub>F</sub> = 50 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C   |      | 160    | 240   | nC    |
| Reverse Recovery Fall Time                       | t <sub>a</sub>          |   |      | 57     |       | ns    |
| Reverse Recovery Rise Time                       | t <sub>b</sub>          |   |      | 23     |       |       |

#### Notes:

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

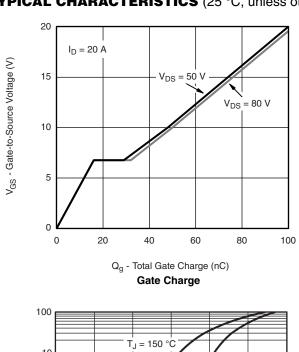
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

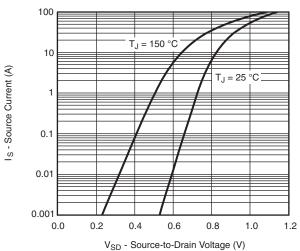


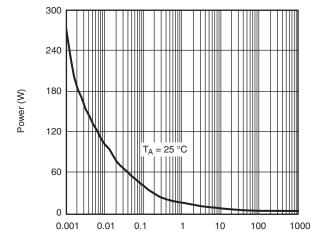


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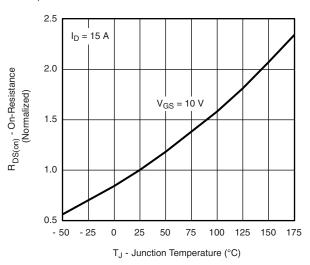




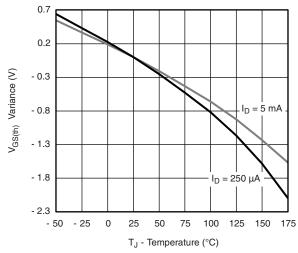


Source-Drain Diode Forward Voltage

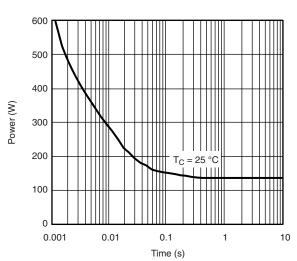
Time (s)
Single Pulse Power, Junction-to-Ambient



#### On-Resistance vs. Junction Temperature

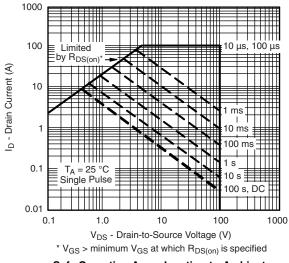


#### Threshold Voltage

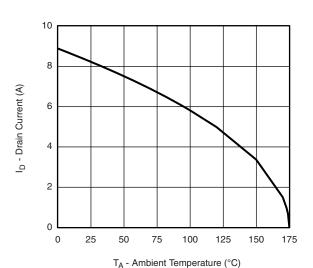


Single Pulse Power, Junction-to-Case

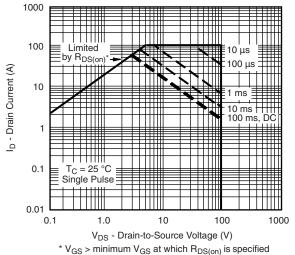




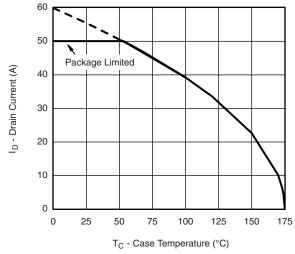




Current Derating\*\*, Junction-to-Ambient



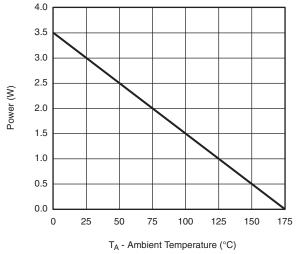
Safe Operating Area, Junction-to-Case

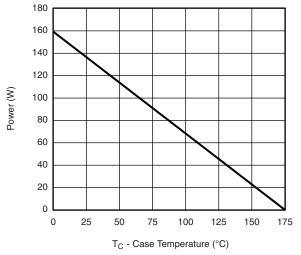


Current Derating\*\*, Junction-to-Case

<sup>\*\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 175 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





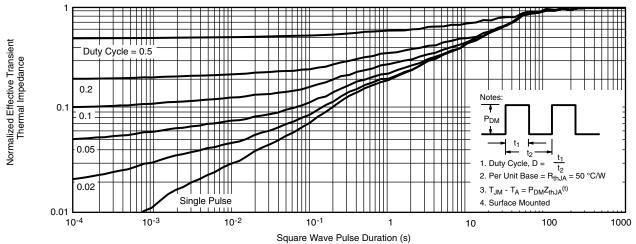


Power Derating\*\*, Junction-to-Ambient

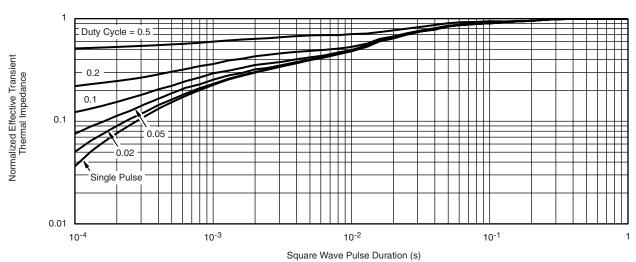
Power Derating\*\*, Junction-to-Case

<sup>\*\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 175$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



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